

Vishay Siliconix

RoHS

HALOGEN FREE

3.2 Ω , Fast Switching Speed, +12 V / +5 V / +3 V / ± 5 V, 4- / 8-Channel Analog Multiplexers

DESCRIPTION

The DG9408E, DG9409E uses BiCMOS wafer fabrication technology that allows the DG9408E, DG9409E to operate on single and dual supplies. Single supply voltage ranges from 3 V to 16 V while dual supply operation is recommended with \pm 3 V to \pm 8 V.

The DG9408E is an 8-channel single-ended analog multiplexer designed to connect one of eight inputs to a common output as determined by a 3-bit binary address (A_0 , A_1 , A_2). The DG9409E is a dual 4-channel differential analog multiplexer designed to connect one of four differential inputs to a common dual output as determined by its 2-bit binary address (A_0 , A_1). Break-before-make switching action to protect against momentary crosstalk between adjacent channels.

As a committed partner to the community and the environment, Vishay Siliconix manufactures this product with lead (Pb)-free device terminations. The DG9408E, DG9409E are offered in a QFN package that has a nickel-palladium-gold device terminations and is represented by the lead (Pb)-free "-E4" suffix. The nickel-palladium-gold device terminations meet all the JEDEC® standards for reflow and MSL ratings.

FEATURES

- 3 V to 16 V single supply or ± 3 V to ± 8 V dual supply operation
- Low on-resistance R_{ON}: 3.2 Ω typ.
- Fast switching: t_{ON} 36 ns, t_{OFF} 24 ns
- Break-before-make guaranteed
- Low leakage
- TTL, CMOS, LV logic (3 V) compatible
- 2500 V ESD protection (HBM)
- Material categorization: for definitions of compliance please see <u>www.vishav.com/doc?99912</u>

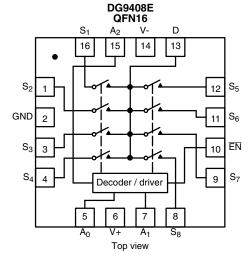
BENEFITS

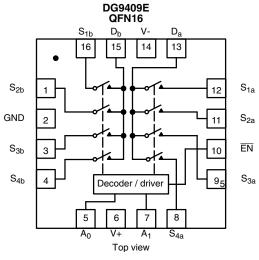
- · Fast switching speed
- · Low switch resistance
- Wide operation voltage range
- Simple logic interface

APPLICATIONS

- · Automatic test equipment
- · Process control and automation
- · Data acquisition systems
- · Meters and instruments
- Medical and healthcare systems
- · Communication systems
- · Audio and video signal routing
- Relay replacement
- · Battery powered systems

FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION





Note

S16-1452-Rev. A, 25-Jul-16

• QFN16 package central exposed pad has no electrical connection inside the chip. It can be connected GND, V+, V-, or left floating.

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TRUTH TABLE AND ORDERING INFORMATION

TRUTH	TRUTH TABLE DG9408E									
A ₂	A ₁	A ₀	EN	ON SWITCH						
Х	Х	Х	1	None						
0	0	0	0	1						
0	0	1	0	2						
0	1	0	0	3						
0	1	1	0	4						
1	0	0	0	5						
1	0	1	0	6						
1	1	0	0	7						
1	1	1	0	8						

TRUTH 1	TRUTH TABLE DG9409E									
A ₁	A ₀	EN	ON SWITCH							
Х	Х	1	None							
0	0	0	1							
0	1	0	2							
1	0	0	3							
1	1	0	4							

X = do not care

For low and high voltage levels for V_{AX} and $V_{\overline{EN}}$ consult "Digital Control" parameters for specific V+ operation. See specifications tables for:

Single supply 12 V

Dual supply V+ = 5 V, V- = -5 V

Single supply 5 V

Single supply 3 V

ORDERING INFORMATION										
TEMP. RANGE	PACKAGE	PART NUMBER	MIN. ORDER / PACK. QUANTITY							
-40 °C to +85 °C	16-pin QFN (4 mm x 4 mm)	DG9408EDN-T1-GE4	Tape and reel, 2500 units							
	(variation 1)	DG9409EDN-T1-GE4	Tape and reel, 2500 units							

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)									
PARAMETER	LIMIT	UNIT							
Voltage referenced V+ to V-	-0.3 to +18								
GND to V-	18	V							
Digital inputs ^a , V _S , V _D		(V-) - 0.3 to (V+) + 0.3							
Current (any terminal except S or D)	30								
Continuous current, S or D		100	mA						
Peak current, S or D (pulsed at 1 ms, 10 % duty cycle max.)		200							
Package solder reflow conditions (lead (Pb)-free assembly) ^d	16-pin (4 x 4 mm) QFN	260 +0 / -5	°C						
Storage temperature		-65 to +150							
Power dissipation (package) b, (T _A = 70 °C)	1880	mW							
ESD human body model (HBM), per ANSI / ESDA / JEDEC® JS	2500	V							
Latch up current, per JESD78	400	mA							

Notes

- a. Signals on SX, DX or INX exceeding V+ or V- will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
- b. All leads soldered or welded to PC board.
- c. Derate 23.5 mW/°C above 70 °C.
- d. Manual soldering with soldering iron is not recommended for leadless components. The QFN is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper lip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



PARAMETER	SYMBOL	TEST CONDITIONS UNLESS OTHERWISE SPEC	TEMP.b	-40	UNIT			
TANAMETER	OTMIDGE	$V_{+} = 12 \text{ V}, \pm 10 \text{ %}, V_{-} = 0$ $V_{A}, V_{\overline{EN}} = 0.8 \text{ V or } 2.4 \text{ V}$		MIN. c	TYP.d	MAX.c	0	
Analog Switch								
Analog signal range ^e	V _{ANALOG}			Full	0	-	12	V
On registance		V+ = 10.8 V, V _D = 2 V or 9 V, I _S =	= 50 mA	Room	-	3.2	7	
On-resistance	R _{ON}	sequence each switch or		Full	-		7.5	
R _{ON} match between channels ^g	ΔR_{ON}			Room	-	-	3.6	Ω
On-resistance flatness i	R _{ON} flatness	$V+ = 10.8 \text{ V}, V_D = 2 \text{ V or } 9 \text{ V}, I_S = 10.8 \text{ V}$	$V+ = 10.8 \text{ V}, V_D = 2 \text{ V or } 9 \text{ V}, I_S = 50 \text{ mA}$				8	
	-			Room	-2	-	2	
Switch off lookage current	I _{S(off)}	\ - - 2.4 \\ \\ - 11 \\ or 1 \\ \\ -	1 \/ or 11 \/	Full	-15	-	15	
Switch off leakage current	ı	$ V_{\overline{EN}} = 2.4 \text{ V}, V_D = 11 \text{ V or } 1 \text{ V}, V_S = 1 \text{ V or } 11 \text{ V}$		Room	-2	-	2	- A
	I _{D(off)}			Full	-15	-	12	nA
Channel on lookage ourrent	ı	$V_{\overline{FN}} = 0 \text{ V}, V_S = V_D = 1 \text{ V or } 1$	11.1/	Room	-2	-	2	
Channel on leakage current	I _{D(on)}	$\mathbf{v}_{EN} = 0 \ \mathbf{v}, \ \mathbf{v}_{S} = \mathbf{v}_{D} = 1 \ \mathbf{v} \ O I$	Full	-15	-	15	<u> </u>	
Digital Control								
Logic high input voltage	V_{INH}			Full	2.4	-	-	V
Logic low input voltage	V _{INL}			Full	-	-	0.8	V
Input current	I _{IN}	$V_{AX} = V_{\overline{EN}} = 2.4 \text{ V or } 0.8 \text{ V}$	/	Full	-1	-	1	μΑ
Dynamic Characteristics								
		V _{S1} = 8 V, V _{S8} = 0 V, (DG940	Room	-	40	71		
Transition time	t _{TRANS}	V _{S1b} = 8 V, V _{S4b} = 0 V, (DG94 see fig. 2	·09E)	Full	-	-	75	
Break-before-make time	t _{BBM}	$V_{S(all)} = V_{DA} = 5 V$	Room	2	20	-	ns	
Break Before make time	rBBM	see fig. 4	Full	-	-	-		
Enable turn-on time	towen			Room	-	36	70	
Litable tarri on time	t _{ON(EN)}	$V_{AX} = 0 \text{ V}, V_{S1} = 5 \text{ V} \text{ (DG940)}$ $V_{AX} = 0 \text{ V}, V_{S1b} = 5 \text{ V} \text{ (DG940)}$		Full	-	-	75	
Enable turn-off time	torr/ EV	see fig. 3	JJL)	Room	-	24	44	
Lilable turn-on time	t _{OFF(EN)}	-		Full	-	-	46	
Charge injection ^e	Q	$C_L = 1 \text{ nF}, V_{GEN} = 0 \text{ V}, R_{GEN} = 0 \text{ V}$	= 0 Ω	Room	-	4.5	-	рС
Off isolation e, h	OIRR	$f = 100 \text{ kHz}, R_L = 1 \text{ k}\Omega$		Room	-	-83	-	dB
Crosstalk e	X _{TALK}	1 – 100 KHZ, NL = 1 KS2		Room	-	-89	-	uВ
Source off capacitance e	C _{S(off)}	f = 1 MHz, V _S = 0 V, V _{EN} = 2.4 V	DG9408E	Room	-	17	-	
Course on capacitance	OS(off)	1 - 1 1011 12, v _S - 0 v, v _{EN} - 2.4 v	DG9409E	Room	-	16	-	
Drain off capacitance e	Co	f = 1 MHz, V _D = 0 V, V _{EN} = 2.4 V	DG9408E	Room	-	134	-	рF
Drain on capacitance -	C _{D(off)}	1 - 1 1011 12, VD - 0 V, VEN = 2.4 V	DG9409E	Room	-	67	-	- -
Drain on capacitance e	Cnr	f = 1 MHz, V _D = 0 V, V _{EN} = 0 V	DG9408E	Room	-	154	-	
Drain on capacitance	C _{D(on)}	1 - 1 WILLS, VD = 0 V, VEN = 0 V	DG9409E	Room	-	86	-	
Power Supplies								
Power supply current	l+	$V_{\overline{EN}} = V_A = 0 \text{ V or V} +$		Room	-	_	1	μΑ



PARAMETER	SYMBOL	TEST CONDITIONS UNLESS OTHERWISE SPEC	S OTHERWISE SPECIFIED		LIMITS -40 °C to +85 °C			UNIT	
TANAMETEN	OTHIDOL	$V_{+} = 5 \text{ V}, V_{-} = -5 \text{ V}, \pm 10 \text{ S}$ $V_{A}, V_{\overline{EN}} = 0.8 \text{ V or } 2 \text{ V f}$	TEMP.b	MIN. c	TYP.d	MAX.c	01111		
Analog Switch				L					
Analog signal range ^e	V _{ANALOG}			Full	-5	-	5	V	
On Besistance		$V+ = 4.5 \text{ V}, V- = -4.5 \text{ V}, V_D = \pm 3.5 \text{ V}$, I _S = 50 mA	Room	-	4	8		
On-Resistance	R_{ON}	sequence each switch or	Full	-	-	8.5			
R _{ON} match between channels ^g	ΔR_{ON}			Room	-	-	3.6	Ω	
On-resistance flatness i	R _{ON} Flatness	$V+ = 4.5 V, V- = -4.5 V, V_D = \pm 3.5 V$	$I_{S} = 50 \text{ mA}$	Room	-	-	8.2		
				Room	-2	-	2		
O the office leading and a	I _{S(off)}	V+ = 5.5, V- = -5.5 V		Full	-15	-	15		
Switch off leakage current a		$V_{\overline{EN}} = 2.4 \text{ V}, V_D = \pm 4.5 \text{ V}, V_S =$	± 4.5 V	Room	-2	-	2		
	I _{D(off)}			Full	-15	-	15	nA	
0, , , , , , , , , , , , , , , , , , ,		V+ = 5.5 V, V- = -5.5 V	Room	-2	-	2	1		
Channel on leakage current a	Channel on leakage current ^a $I_{D(on)}$ $V_{\overline{EN}} = 0 \text{ V, V}$				-15	-	15	1	
Digital Control				I.		ı		L	
Logic high input voltage	V _{INH}			Full	2	-	-	V	
Logic low input voltage	V _{INL}			Full	-	-	0.8		
Input current ^a	I _{IN}	$V_{AX} = V_{\overline{EN}} = 2 \text{ V or } 0.8 \text{ V}$		Full	-1	-	1	μΑ	
Dynamic Characteristics									
		$V_{S1} = 3.5 \text{ V}, V_{S8} = -3.5 \text{ V}, (DG9)$	Room	-	47	65			
Transition time ^e	t _{TRANS}	$V_{S1b} = 3.5 \text{ V}, V_{S4b} = -3.5 \text{ V}, (DG)$ see fig. 2	9409E)	Full	-	-	70		
Break-before-make time e	tonu	$V_{S(all)} = V_{DA} = 3.5 \text{ V}$	Room	1	13	-			
Break Before make time	t _{BBM}	see fig. 4		Full		-	-	ns	
Enable turn-on time e	towen			Room	-	54	70		
Lilable turn-on time	t _{ON(EN)}	$V_{AX} = 0 \text{ V}, V_{S1} = 3.5 \text{ V} (DG94)$ $V_{AX} = 0 \text{ V}, V_{S1b} = 3.5 \text{ V} (DG94)$	08E)	Full	-	-	76		
Enable turn-off time e	t	see fig. 3	+03L)	Room	-	28	40		
Lilable turn-on time	t _{OFF(EN)}			Full	-	-	43		
Source off capacitance e	Ca., 15	f = 1 MHz, V _S = 0 V, V _{EN} = 2 V	DG9408E	Room	-	15	-		
Source on capacitance	$C_{S(off)}$	1 - 1 WII 12, Vg - 0 V, VEN - 2 V	DG9409E	Room	-	14	-		
Drain off capacitance e	Cn: #	f = 1 MHz, V _D = 0 V, V _{EN} = 2 V	DG9408E	Room	-	126	-	nE	
Drain on capacitance -	$C_{D(off)}$	I = I IVII IZ, VD = U V, VEN = 2 V	DG9409E	Room		63	_	pF	
Drain on capacitance e	_	f = 1 MHz, V _D = 0 V, V FN = 0 V	DG9408E	Room	-	153	-		
Drain on capacitance e $C_{D(on)}$ $f = 1$		V = V = V = V = V = V = V = V = V = V =	DG9409E			89	-		
Power Supplies									
Power supply current	l+	$V_{\overline{EN}} = VA = 0 V \text{ or } V+$		Room	=	-	1		
i ower supply current	-	v _{EN} = vA = 0 v or v+		Room	-1	-	-	μΑ	



PARAMETER	SYMBOL	TEST CONDITIONS UNLESS OTHERWISE SPEC	TEMP.b	-40	UNIT			
		$V_{+} = 5 \text{ V}, \pm 10 \text{ %}, V_{-} = 0 \text{ V}$ $V_{A}, V_{\overline{EN}} = 0.8 \text{ V or } 2 \text{ V}^{\text{ f}}$		MIN. c	TYP. d	MAX.c		
Analog Switch								
Analog signal range ^e	V _{ANALOG}			Full	0	-	5	V
On-resistance	R _{ON}	$V+ = 4.5 \text{ V}, V_D \text{ or } V_S = 1 \text{ V or } 3.5 \text{ V},$	Room Full	-	6.8	10.5 11	_	
R _{ON} match between channels ^g	ΔR _{ON}			Room	-	-	3.6	Ω
On-resistance flatness i	R _{ON} Flatness	$V+ = 4.5 \text{ V}, V_D = 1 \text{ V or } 3.5 \text{ V}, I_S = 1 \text{ V}$	= 50 mA	Room	-	-	9	
				Room	-2	-	2	
Outlab afficience assument 9	I _{S(off)}	V+ = 5.5 V		Full	-15	-	15	
Switch off leakage current a		$V_S = 1 \text{ V or } 4 \text{ V}, V_D = 4 \text{ V or}$	1 V	Room	-2	-	2	١.,
	I _{D(off)}		Full	-15	-	15	n/	
01111		V+ = 5.5 V	V+ = 5.5 V			-	2	
Channel on leakage current a	I _{D(on)}	$V_D = V_S = 1 \text{ V or 4 V, sequence each}$	n switch on	Full	-15	-	15	
Digital Control								
Logic high input voltage	V _{INH}	V 5V		Full	2	-	-	
Logic low input voltage	V _{INL}	V+ = 5 V	Full	-	-	0.8	٧	
Input current a	I _{IN}	$V_{AX} = V_{\overline{EN}} = 2 \text{ V or } 0.8 \text{ V}$		Full	-1	-	1	μA
Dynamic Characteristics								
		$V_{S1} = 3.5 \text{ V}, V_{S8} = 0 \text{ V}, (DG9408E)$		Room	-	79	97	
Transition time ^e	t _{TRANS}	$V_{S1b} = 3.5 \text{ V}, V_{S4b} = 0 \text{ V}, (DG9-see fig. 2}$	409E)	Full	-	-	112	
Break-before-make time e	+	$V_{S(all)} = V_{DA} = 3.5 \text{ V}$	Room	2	35	-		
break-before-make time	t _{OPEN}	see fig. 4		Full	1	-	-	ns
Enable turn on time e	+ ===			Room	-	83	95	
Enable turn-on time ^e	t _{ON(EN)}	$V_{AX} = 0 \text{ V}, V_{S1} = 3.5 \text{ V} (DG94)$		Full	-	-	116	
Enable turn-off time e	+	$V_{AX} = 0 \text{ V}, V_{S1b} = 3.5 \text{ V} \text{ (DG94)}$ see fig. 3	109E)	Room	-	36	57	
Enable turn-on time s	t _{OFF(EN)}	Ğ		Full	-	-	61	
Charge injection e	Q	$C_L = 1 \text{ nF, } R_{GEN} = 0, V_{GEN} =$	0 V	Room	-	3.7	=	p(
Off isolation e, h	OIRR	P. = 1 k0 f = 100 kl =		Room	-	-83	=.	dl
Crosstalk e	X _{TALK}	$R_L = 1 \text{ k}\Omega, f = 100 \text{ kHz}$		Room	-	-90	-	Lui
Source off capacitance e	C _{S(off)}	f = 1 MHz, V _S = 0 V, V _{EN} = 0 V	DG9408E	Room	-	19	-	
	. ,		DG9409E	Room	-	18	-	-
Drain off capacitance e	$C_{\text{D(off)}}$	$f = 1 \text{ MHz}, V_D = 0 \text{ V}, V_{\overline{EN}} = 2 \text{ V}$	DG9408E DG9409E	Room Room	-	149 74	-	pl
Drain on capacitance e	C _{D(on)}	$f = 1 \text{ MHz}, V_D = 0 \text{ V}, V_{\overline{EN}} = 0 \text{ V}$	DG9408E	Room	-	170	-	-
Dower Cumplies			DG9409E	Room	-	94		
Power Supplies	l+			1				

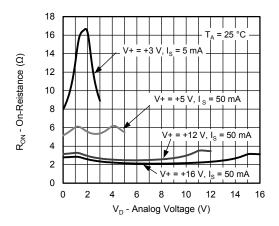


PARAMETER Analog Switch Analog signal range e On-resistance	SYMBOL	TEST CONDITIONS UNLESS OTHERWISE SPECII $V+=3 V, \pm 10 \%, V-=0 V$	FIED			LIMITS		I
Analog signal range ^e		V+ = 3 V. + 10 %. V- = 0 V	UNLESS OTHERWISE SPECIFIED			40 00 +05 00		
Analog signal range ^e	I.	$V_{\overline{EN}} = 0.4 \text{ V or } 1.8 \text{ V}^{\text{f}}$			MIN. c	TYP. d	MAX.c	
On-resistance	V _{ANALOG}			Full	0	-	3	V
J 55.5tar100	R _{ON}	$V+ = 2.7 \text{ V}, V_D = 0.5 \text{ V or } 2.2 \text{ V}, I_S$	V+ = 2.7 V, V _D = 0.5 V or 2.2 V, I _S = 5 mA		-	13	25.5	
R _{ON} match between channels ^g	ΔR _{ON}			Room		-		Ω
On-resistance flatness i	R _{ON} Flatness	$V+ = 2.7 \text{ V}, V_D = 0.5 \text{ V or } 2.2 \text{ V}, I_S$	= 5 mA	Room	-	-	13	
	I _{S(off)}			Room	-2	-	2	
Switch off leakage current ^a		V+ = 3.3 V $V_S = 2 V \text{ or } 1 V, V_D = 1 \text{ or } 2^{\circ}$	V	Room				ŀ
	$I_{D(off)}$			Full	MIN. c TYP. d MAX.c uill 0 - 3 com - 13 25.5 uill 26.5 com - 13 com - 13 com - 13 com - 2 - 2 uill -15 - 15 com -2 - 2 uill -15 - 15 com -2 - 2 uill -15 - 15 com -2 - 15 com -2 - 15 com -2 - 2 uill -15 - 15 com -2 - 2 uill -1 - 1 com -2 - 2 uill -1 - 1 com - 169 245 uill 1 com - 202 255 uill 272 com - 72 97 uill 104 com - 2.1 - com - 207 com - 90 - com - 19 - com - 159 com - 179 - com - 179 com - 179	nA		
	_	V+ = 3.3 V		Room				
Channel on leakage current ^a	I _{D(on)}	$V_D = V_S = 1 \text{ V or } 2 \text{ V}$, sequence each switch on			-15	-	15	
Digital Control	l .					<u> </u>		
Logic high input voltage	V _{INH}				1.8	-	-	V
Logic low input voltage	V _{INL}			Full	-	-	0.4	V
Input current ^a	I _{IN}	$V_{AX} = V_{\overline{EN}} = 1.8 \text{ V or } 0.4 \text{ V}$	Full	-1	-	1	μΑ	
Dynamic Characteristics								
Transition time	t _{TRANS}	$V_{S1} = 1.5 \text{ V}, V_{S8} = 0 \text{ V}, (DG940 \text{ V}_{S1b} = 1.5 \text{ V}, V_{S4b} = 0 \text{ V}, (DG940 \text{ V}_{S1b} = 0 \text{ V})$	08E) -09E)	Room Full				
		see fig. 2			2	06		l
Break-before-make time	t _{BBM}	$V_{S(all)} = V_{DA} = 1.5 V$ see fig. 4		Full	-	-	-	ns
Enable turn-on time	tou su			Room	-	202	255	
Enable tarri on time	t _{ON(EN)}	$V_{AX} = 0 \text{ V}, V_{S1} = 1.5 \text{ V} (DG940 \text{ V}_{AX} = 0 \text{ V}, V_{S1b} = 1.5 \text{ V} (DG940 \text{ V}_{AX} = 0 \text{ V}, V_{S1b} = 1.5 \text{ V} (DG940 \text{ V}_{AX} = 0 \text{ V}, V_{S1b} = 1.5 \text{ V})$		Full	-	-	272	
Enable turn-off time	t _{OFF(EN)}	see fig. 3	,o_,	Room	-	72	97	
	` ′			Full	-	-	104	
Charge injection e	Q	$C_L = 1 \text{ nF}, R_{GEN} = 0, V_{GEN} = 0$) V	Room			-	рC
Off isolation e, h	OIRR	$f = 100 \text{ kHz}, R_L = 1 \text{ k}\Omega$		Room	-		-	dB
Crosstalk e	X _{TALK}	, , ,		Room	-		-	
Source off capacitance e	C _{S(off)}	f = 1 MHz, V _S = 0 V, V _{EN} = 1.8 V	DG9408E	Room	-		-	1
	` ′		DG9409E DG9408E	Room				ł
Drain off capacitance e	C _{D(off)}	$f = 1 \text{ MHz}, V_D = 0 \text{ V}, V_{\overline{EN}} = 1.8 \text{ V}$	DG9408E DG9409E	Room			-	рF
			DG9409E	Room			-	ĺ
Drain on capacitance e	C _{D(on)}	$f = 1 \text{ MHz}, V_D = 0 \text{ V}, V_{\overline{EN}} = 0 \text{ V}$	MHz, $V_D = 0 \text{ V}$, $V_{\overline{EN}} = 0 \text{ V}$ DG9409E					
Power Supplies								
Power supply current	I+	$V_{\overline{EN}} = V_A = 0 \text{ V or V} +$		Room	-	-	1	μΑ

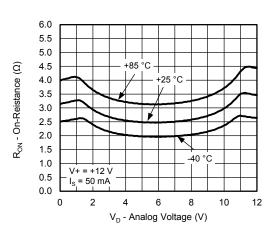
- a. Leakage parameters are guaranteed by worst case test condition and not subject to production test.
- b. Room = 25 °C, full = as determined by the operating temperature suffix.
- The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
- d. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- e. Guaranteed by design, not subject to production test.
- V_{IN} = input voltage to perform proper function. $\Delta R_{DON} = R_{DON} \text{ max.} R_{DON} \text{ min.}$
- h. Worst case isolation occurs on channel 4 due to proximity to the drain pin.
- i. R_{DON} flatness is measured as the difference between the minimum and maximum measured values across a defined analog signal.



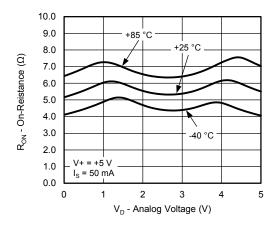
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



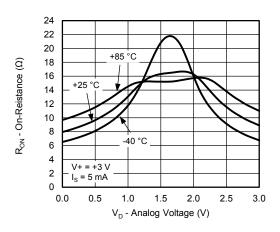
On-Resistance vs. Analog Voltage



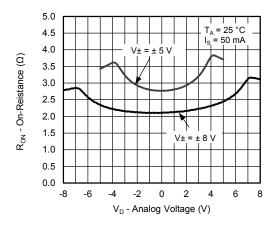
On-Resistance vs. Analog Voltage



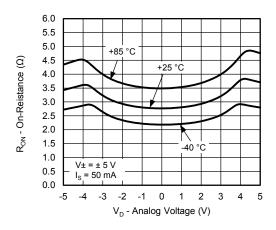
On-Resistance vs. Analog Voltage



On-Resistance vs. Analog Voltage



On-Resistance vs. Analog Voltage



On-Resistance vs. Analog Voltage



100

50

0

-50

-100

-150

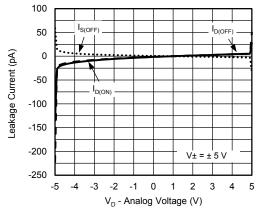
-200

-250

0 1 2 3 4 5 6 7 8 9

Leakage Current (pA)

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Leakage Current vs. Analog Voltage

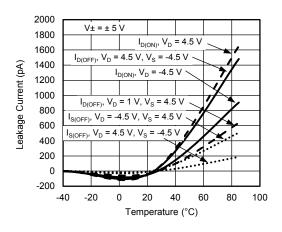


Leakage Current vs. Analog Voltage

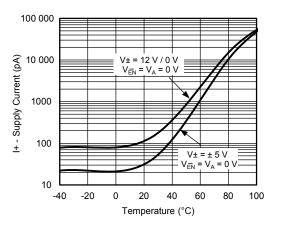
V_D - Analog Voltage (V)

= +12 V / 0 V

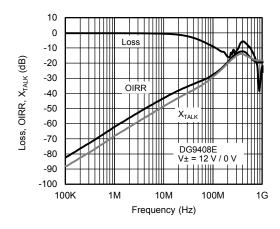
10 11 12



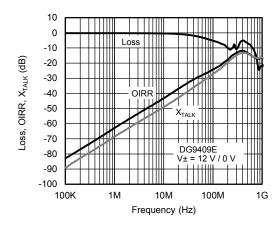
Leakage Current vs. Temperature



Supply Current vs. Temperature



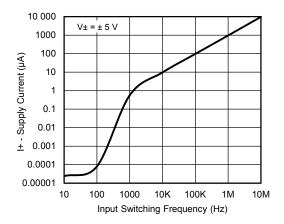
Loss, OIRR, X_{TALK} vs. Frequency



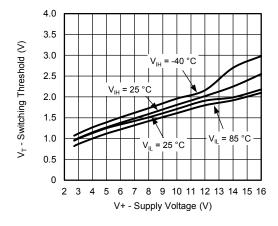
Loss, OIRR, X_{TALK} vs. Frequency



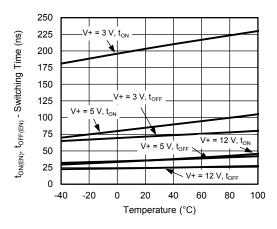
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



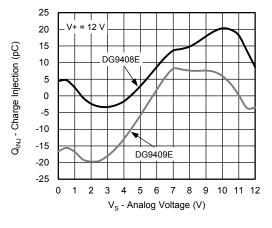
Supply Current vs. Input Switching Frequency



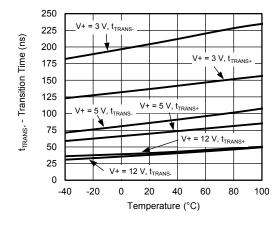
Switching Threshold vs. Supply Voltage



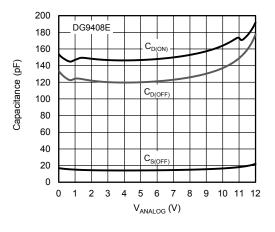
Switching Time vs. Temperature



Charge Injection vs. Analog Voltage



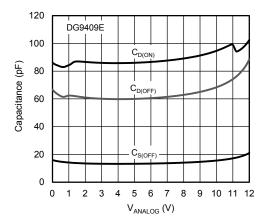
Transition Time vs. Temperature



Capacitance vs. Analog Voltage



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Capacitance vs. Analog Voltage

SCHEMATIC DIAGRAM (Typical Channel)

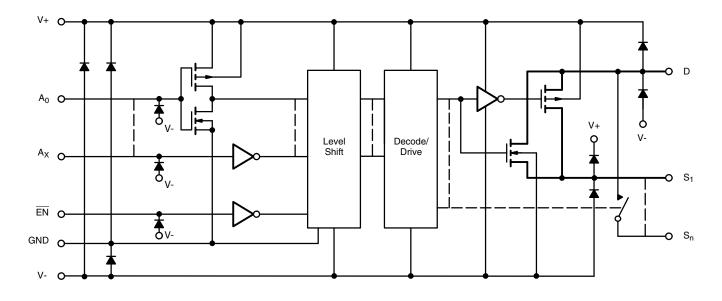


Fig. 1 -



TEST CIRCUITS

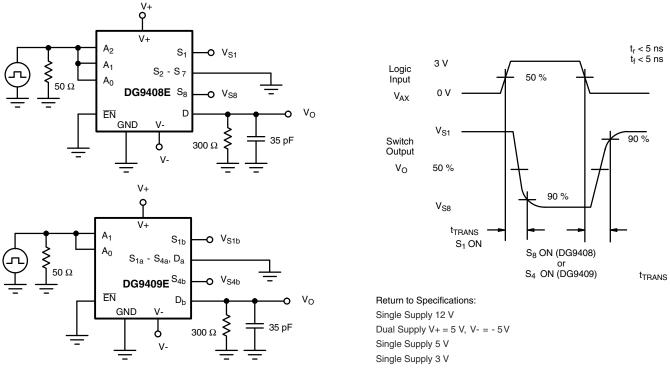


Fig. 2 - Transition Time

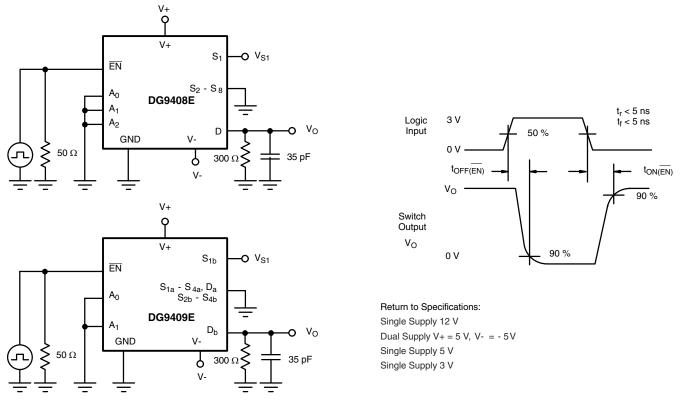


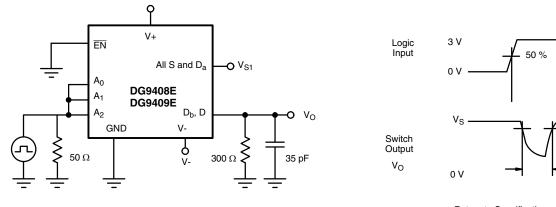
Fig. 3 - Enable Switching Time

90 %

tOPEN

 $t_r < 5 \text{ ns} \\ t_f < 5 \text{ ns}$

TEST CIRCUITS



Return to Specifications:

Single Supply 12 V Dual Supply V+ = 5 V, V- = -5 VSingle Supply 5 V Single Supply 3 V

Fig. 4 - Break-Before-Make Interval

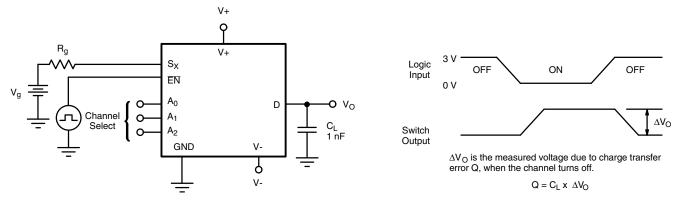


Fig. 5 - Charge Injection

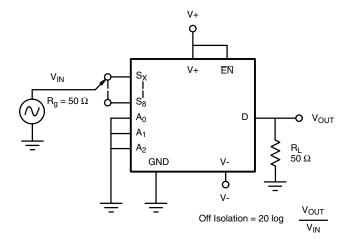


Fig. 6 - Off Isolation

TEST CIRCUITS

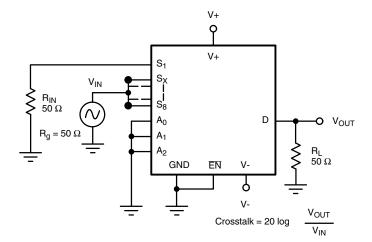


Fig. 7 - Crosstalk

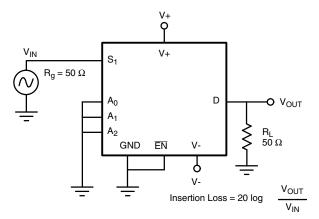


Fig. 8 - Insertion Loss

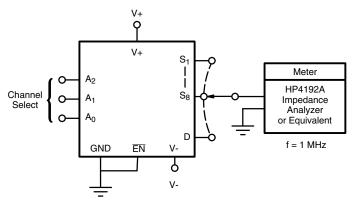
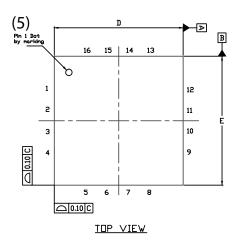


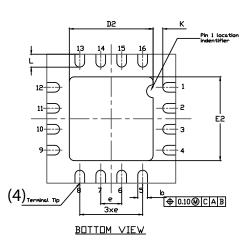
Fig. 9 - Source Drain Capacitance

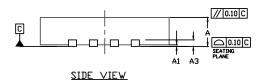
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QFN 4x4-16L Case Outline







			VARIATION 1				VARIATION 2					
DIM	МІ	LLIMETERS ⁽¹⁾			INCHES		M	ILLIMETER	S ⁽¹⁾		INCHES	
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
Α	0.75	0.85	0.95	0.029	0.033	0.037	0.75	0.85	0.95	0.029	0.033	0.037
A1	0	-	0.05	0	-	0.002	0	-	0.05	0	-	0.002
A3	0.20 ref.			0.008 ref.			0.20 ref.					
b	0.25	0.30	0.35	0.010	0.012	0.014	0.25	0.30	0.35	0.010	0.012	0.014
D		4.00 BSC		0.157 BSC		4.00 BSC						
D2	2.0	2.1	2.2	0.079	0.083	0.087	2.5	2.6	2.7	0.098	0.102	0.106
е	0.65 BSC				0.026 BSC		0.65 BSC				0.026 BSC	
Е		4.00 BS0			0.157 BSC			4.00 BSC			0.157 BSC	
E2	2.0	2.1	2.2	0.079	0.083	0.087	2.5	2.6	2.7	0.098	0.102	0.106
K		0.20 min		0.008 min. 0.20 min.		0.008 min. 0.20 min. 0.00		0.008 min.				
L	0.5	0.6	0.7	0.020	0.024	0.028	0.3	0.4	0.5	0.012	0.016	0.020
N ⁽³⁾		16			16		16 16					
Nd ⁽³⁾		4			4		4 4			4		
Ne ⁽³⁾		4			4			4			4	

Notes

- (1) Use millimeters as the primary measurement.
- (2) Dimensioning and tolerances conform to ASME Y14.5M. 1994.
- (3) N is the number of terminals. Nd and Ne is the number of terminals in each D and E site respectively.
- (4) Dimensions b applies to plated terminal and is measured between 0.15 mm and 0.30 mm from terminal tip.
- (5) The pin 1 identifier must be existed on the top surface of the package by using identification mark or other feature of package body.
- (6) Package warpage max. 0.05 mm.

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